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Application/Control No.	Applicant(s)/Patent under Reexamination	r
10/608,108	ANDO, HIROTAKE	
Examiner	Art Unit	
VAN T. PHAM	2627	

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	SEARCHED			
Class	Subclass	Date	Examiner	
369	44.29, 44.35, 44.36.	6/27/2006 Upclated on	VP Vp	
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INT	INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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